

**GTM****CORPORATION**ISSUED DATE :2005/02/23  
REVISED DATE :2006/11/09C**GSC9435****P-CHANNEL ENHANCEMENT MODE POWER MOSFET**

BVDSS	-30V
RDS(ON)	50mΩ
ID	-5.3A

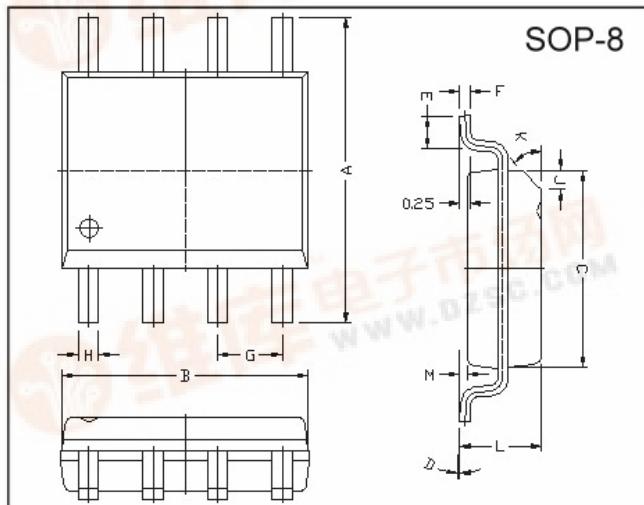
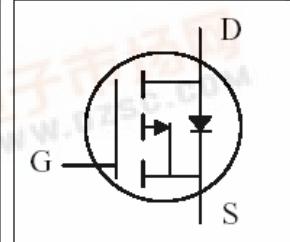
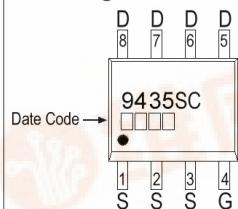
**Description**

The GSC9435 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**Features**

- \*Simple Drive Requirement
- \*Lower On-resistance
- \*Fast Switching

**Package Dimensions****Marking :**

REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.80	6.20	M	0.10	0.25
B	4.80	5.00	H	0.35	0.49
C	3.80	4.00	L	1.35	1.75
D	0°	8°	J	0.375 REF.	
E	0.40	0.90	K	45°	
F	0.19	0.25	G	1.27 TYP.	

**Absolute Maximum Ratings**

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	-30	V
Gate-Source Voltage	V <sub>GS</sub>	±16	V
Continuous Drain Current	I <sub>D</sub> @TA=25°C	-5.3	A
Continuous Drain Current	I <sub>D</sub> @TA=70°C	-4.7	A
Pulsed Drain Current <sup>1</sup>	I <sub>DM</sub>	-20	A
Total Power Dissipation	P <sub>D</sub> @TA=25°C	2.5	W
Linear Derating Factor		0.02	W/°C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 ~ +150	°C

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-ambient Max.	R <sub>thj-amb</sub>	50	°C/W

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## Electrical Characteristics ( $T_j = 25^\circ\text{C}$ unless otherwise specified)

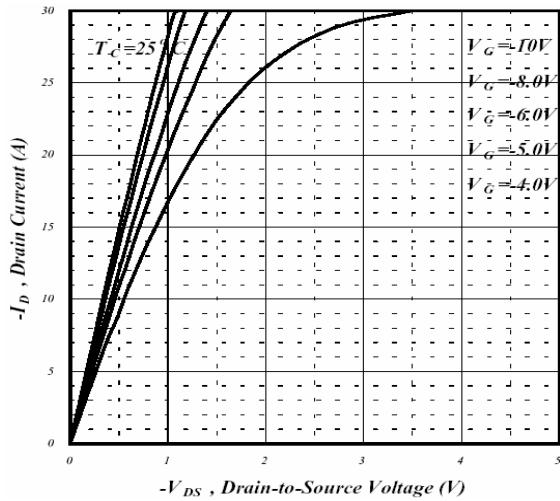
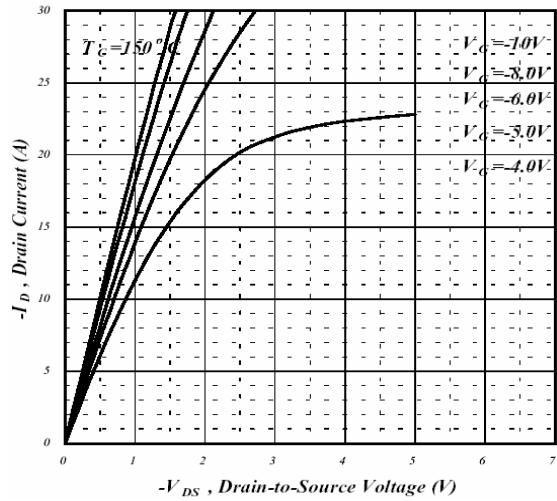
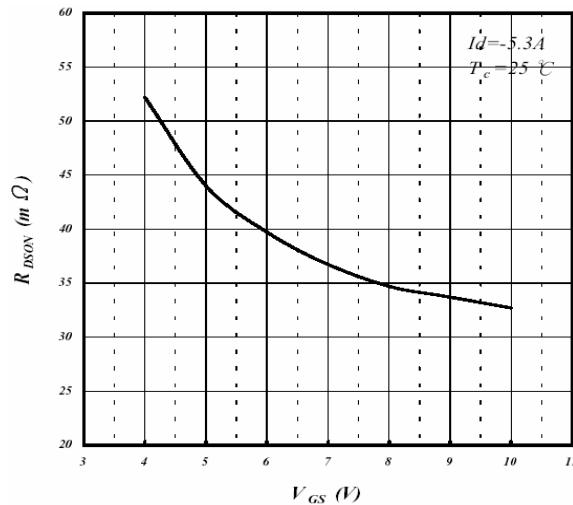
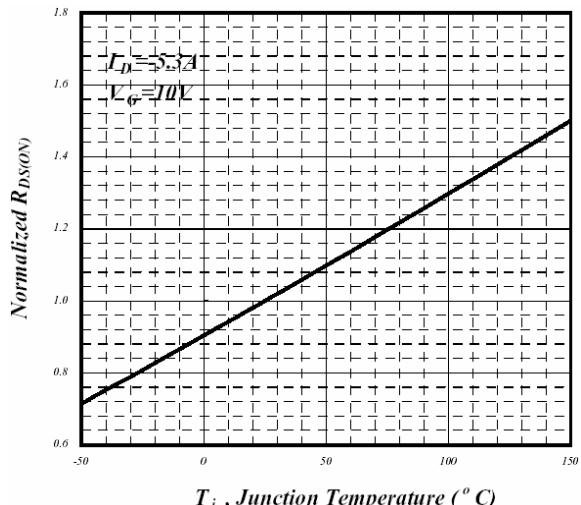
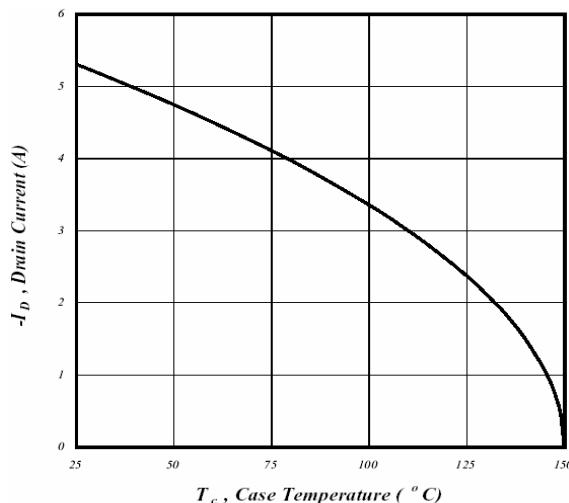
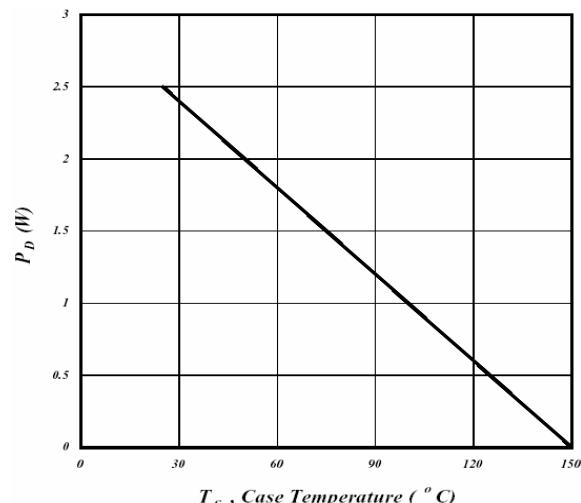
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	-30	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=-250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}} / \Delta T_j$	-	-0.037	-	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D=-1\text{mA}$
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	-1.0	-	-3.0	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=-250\mu\text{A}$
Forward Transconductance	$\text{g}_{\text{fs}}$	-	10	-	S	$\text{V}_{\text{DS}}=-10\text{V}, \text{I}_D=-5.3\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 16\text{V}$
Drain-Source Leakage Current( $T_j=25^\circ\text{C}$ )	$\text{I}_{\text{DSS}}$	-	-	-1	uA	$\text{V}_{\text{DS}}=-30\text{V}, \text{V}_{\text{GS}}=0$
Drain-Source Leakage Current( $T_j=70^\circ\text{C}$ )		-	-	-5	uA	$\text{V}_{\text{DS}}=-24\text{V}, \text{V}_{\text{GS}}=0$
Static Drain-Source On-Resistance	$\text{R}_{\text{DS(ON)}}$	-	-	50	m $\Omega$	$\text{V}_{\text{GS}}=-10\text{V}, \text{I}_D=-5.3\text{A}$
		-	-	90		$\text{V}_{\text{GS}}=-4.5\text{V}, \text{I}_D=-4.2\text{A}$
Total Gate Charge <sup>2</sup>	$\text{Q}_g$	-	28	-	nC	$\text{I}_D=-5.3\text{A}$ $\text{V}_{\text{DS}}=-15\text{V}$ $\text{V}_{\text{GS}}=-10\text{V}$
Gate-Source Charge	$\text{Q}_{\text{gs}}$	-	3	-		
Gate-Drain ("Miller") Change	$\text{Q}_{\text{gd}}$	-	7	-		
Turn-on Delay Time <sup>2</sup>	$\text{T}_{\text{d(on)}}$	-	9	-	ns	$\text{V}_{\text{DS}}=-15\text{V}$ $\text{I}_D=-1\text{A}$ $\text{V}_{\text{GS}}=-10\text{V}$ $\text{R}_G=6\Omega$ $\text{R}_D=15\Omega$
Rise Time	$\text{T}_r$	-	15	-		
Turn-off Delay Time	$\text{T}_{\text{d(off)}}$	-	75	-		
Fall Time	$\text{T}_f$	-	40	-		
Input Capacitance	$\text{C}_{\text{iss}}$	-	745	-	pF	$\text{V}_{\text{GS}}=0\text{V}$ $\text{V}_{\text{DS}}=-15\text{V}$ $f=1.0\text{MHz}$
Output Capacitance	$\text{C}_{\text{oss}}$	-	440	-		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	120	-		

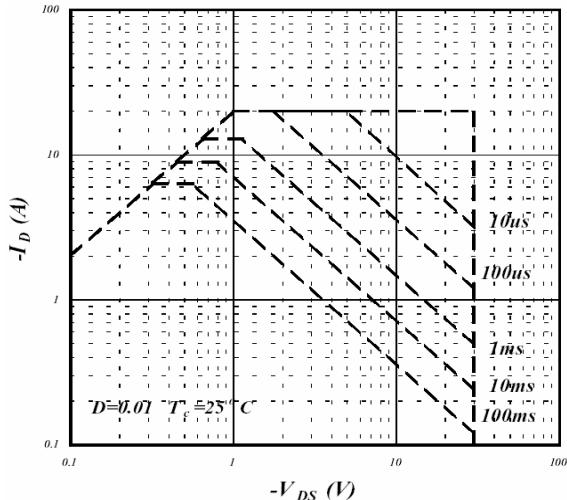
## Source-Drain Diode

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Forward On Voltage <sup>2</sup>	$\text{V}_{\text{SD}}$	-	-0.75	-1.2	V	$\text{I}_S=-2.6\text{A}, \text{V}_{\text{GS}}=0\text{V}, \text{T}_j=25^\circ\text{C}$
Continuous Source Current (Body Diode)	$\text{I}_S$	-	-	-2.6	A	$\text{V}_D=\text{V}_G=0\text{V}, \text{V}_S=-1.2\text{V}$
Pulsed Source Current (Body Diode) <sup>1</sup>	$\text{I}_{\text{SM}}$	-	-	-20	A	

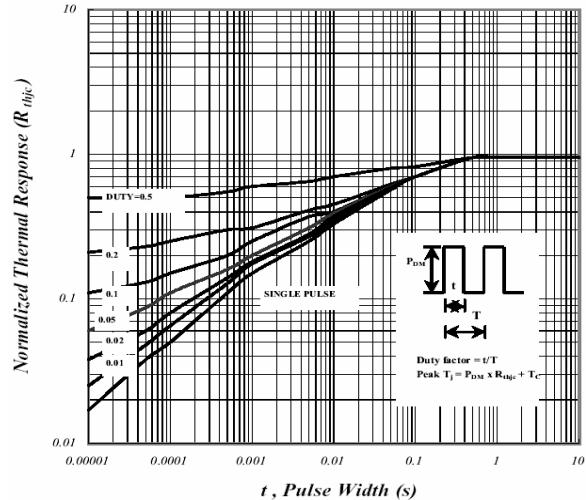
Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width  $\leq 300\text{us}$ , duty cycle  $\leq 2\%$ .

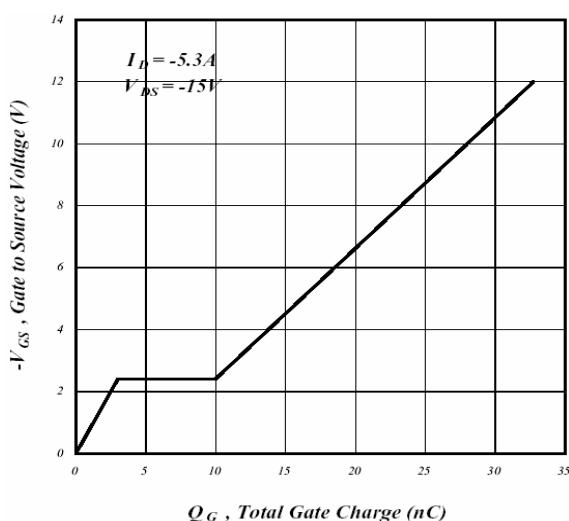
**Characteristics Curve****Fig 1. Typical Output Characteristics****Fig 2. Typical Output Characteristics****Fig 3. On-Resistance v.s. Gate Voltage****Fig 4. Normalized On-Resistance v.s. Junction Temperature****Fig 5. Maximum Drain Current v.s. Case Temperature****Fig 6. Type Power Dissipation**



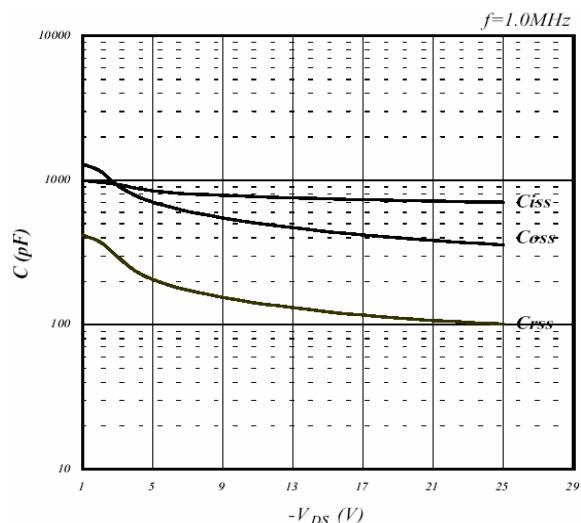
**Fig 7. Maximum Safe Operating Area**



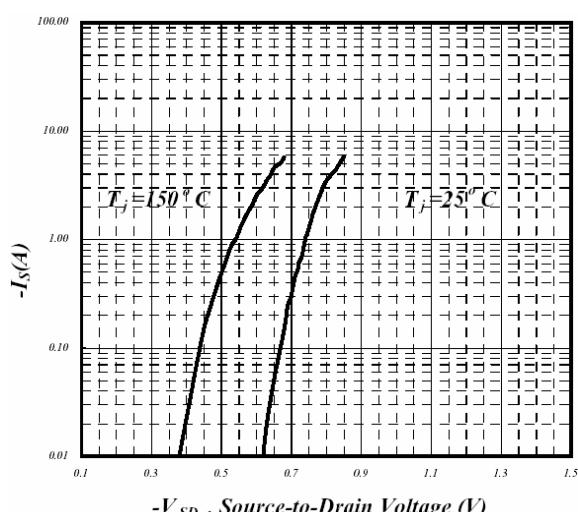
**Fig 8. Effective Transient Thermal Impedance**



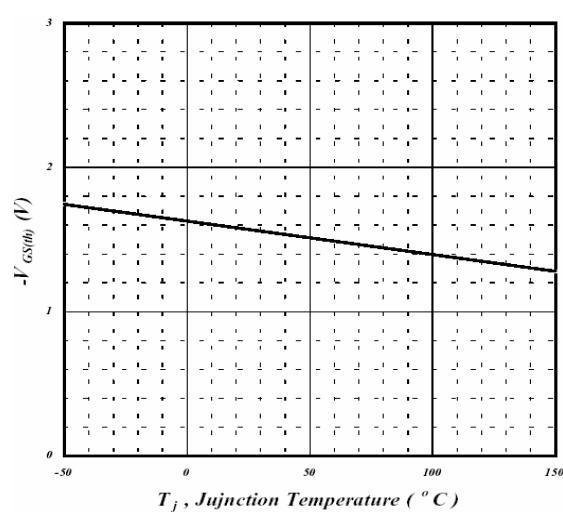
**Fig 9. Gate Charge Characteristics**



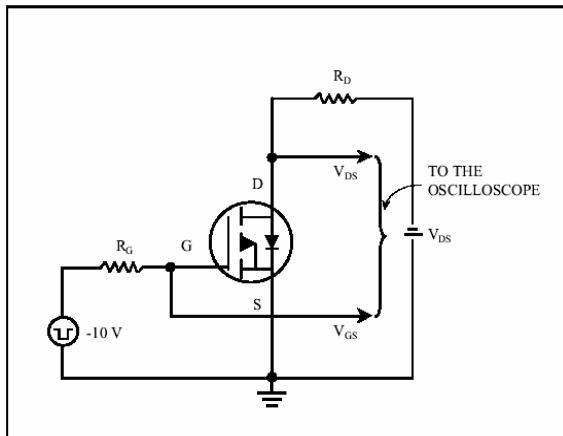
**Fig 10. Typical Capacitance Characteristics**



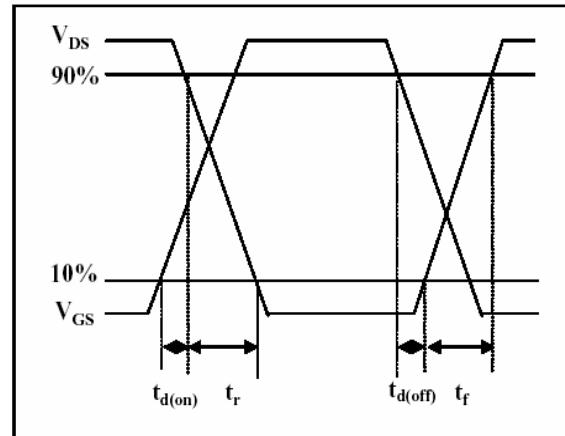
**Fig 11. Forward Characteristics of Reverse Diode**



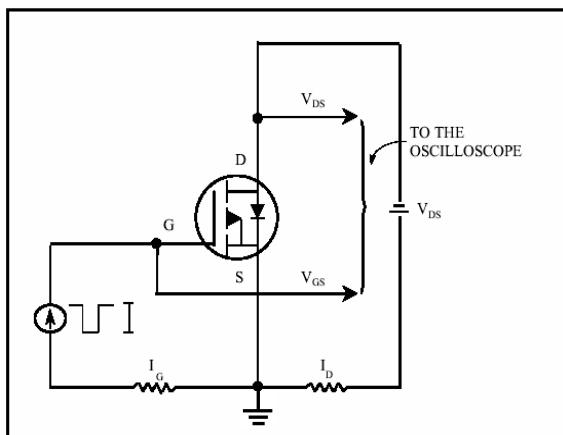
**Fig 12. Gate Threshold Voltage v.s. Junction Temperature**



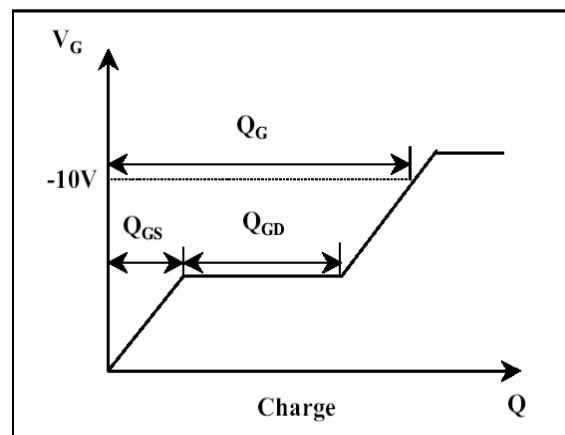
**Fig 13. Switching Time Circuit**



**Fig 14. Switching Time Waveform**



**Fig 15. Gate Charge Circuit**



**Fig 16. Gate Charge Waveform**

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